

Search Notes

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Examiner

Hieu P. Nguyen

Applicant(s)/Patent under
Reexamination

OSMAN ET AL.

Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner
330	51	7/24/2007	HN
330	295	7/24/2007	HN
330	133	8/1/2007	HN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
MOTTOLA STEVEN J	7/29/2007	HN
EAST UPDATE SEARCH	12/7/2007	HN